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AOD464

N-Channel Enhancement Mode Field Effect Transistor

General Description

The AOD464 uses advanced trench technology and design to provide excellent $R_{\rm DS(ON)}$ with low gate charge. This device is suitable for use in high voltage synchronous rectification , load switching and general purpose applications.

- -RoHS Compliant
- -Halogen Free*

Features

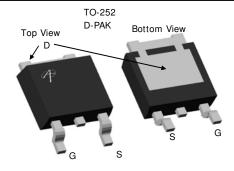
 $V_{DS}(V) = 105V$

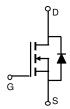
 $I_D = 40 A$ (V_{GS} = 10V)

 $R_{DS(ON)}$ < 28 m Ω (V_{GS} =10V) @ 20A

 $R_{DS(ON)}$ < 31 m Ω (V_{GS} = 6V)

100% UIS Tested! 100% Rg Tested!





Absolute Maximum	Ratings T _A =25°C unle	ess otherwise no	ted		
Parameter		Symbol	Maximum	Units	
Drain-Source Voltage		V_{DS}	105	V	
Gate-Source Voltage		V_{GS}	±25	V	
Continuous Drain	T _C =25°C		40		
Current	T _C =100°C	I _D	28	Α	
Pulsed Drain Current ^C		I _{DM}	80		
Avalanche Current ^C		I _{AR}	20	Α	
Repetitive avalanche energy L=0.1mH ^C		E _{AR}	20	mJ	
	T _C =25°C	Р	100	W	
Power Dissipation ^B	T _C =100°C	$-P_{D}$	50	T vv	
	T _A =25°C	P	2.3	14/	
Power Dissipation A	T _A =70°C	P _{DSM}	1.5	W	
Junction and Storage Temperature Range		T _J , T _{STG}	-55 to 175	°C	
Charmal Charactari	-1!			•	

Thermal Characteristics						
Parameter	Symbol	Тур	Max	Units		
Maximum Junction-to-Ambient A	t ≤ 10s	$R_{\scriptscriptstyle{ hetaJA}}$	15	18	°C/W	
Maximum Junction-to-Ambient A	Steady-State	Г∖θЈА	45	55	°C/W	
Maximum Junction-to-Case B	Steady-State	$R_{\theta JC}$	1	1.5	°C/W	

Electrical Characteristics (T_J=25°C unless otherwise noted)

Symbol	Parameter	Conditions		Min	Тур	Max	Units
STATIC F	PARAMETERS						
BV_{DSS}	Drain-Source Breakdown Voltage	I _D =10mA, V _{GS} =0V		105			V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =84V, V _{GS} =0V				1	μА
			T _J =55°C			5	μΑ
I_{GSS}	Gate-Body leakage current	V _{DS} =0V, V _{GS} =±25V				100	nA
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}$, $I_D=250\mu A$		2.5	3.2	4	V
$I_{D(ON)}$	On state drain current	V _{GS} =10V, V _{DS} =5V		80			Α
R _{DS(ON)}	Static Drain-Source On-Resistance	V _{GS} =10V, I _D =20A			21.5	28	mO
			T _J =125°C		32	40	mΩ
		V_{GS} =6V, I_D =20A		24	31	mΩ	
g _{FS}	Forward Transconductance	V _{DS} =5V, I _D =20A			50		S
V_{SD}	Diode Forward Voltage	I _S =1A, V _{GS} =0V		0.73	1	V	
Is	I _S Maximum Body-Diode Continuous Current					55	Α
DYNAMIC	PARAMETERS						
C _{iss}	Input Capacitance	V _{GS} =0V, V _{DS} =25V, f=1MHz			2038	2445	pF
C _{oss}	Output Capacitance				204		pF
C _{rss}	Reverse Transfer Capacitance				85		pF
R_g	Gate resistance	V _{GS} =0V, V _{DS} =0V, f=1MHz			1.3	1.56	Ω
SWITCHI	NG PARAMETERS						
Q _g (10V)	Total Gate Charge	V _{GS} =10V, V _{DS} =50V, I _D =20A			38.5	46	nC
Q_{gs}	Gate Source Charge				8		nC
Q_{gd}	Gate Drain Charge				10		nC
$t_{D(on)}$	Turn-On DelayTime				12.7		ns
t _r	Turn-On Rise Time	V_{GS} =10V, V_{DS} =50V, R_L =2.7 Ω , R_{GEN} =3 Ω			8.2		ns
$t_{D(off)}$	Turn-Off DelayTime				31.5		ns
t _f	Turn-Off Fall Time				11.2		ns
t _{rr}	Body Diode Reverse Recovery Time	I _F =20A, dI/dt=100A/μs			59.6	74	ns
Q_{rr}	Body Diode Reverse Recovery Charge	I _F =20A, dI/dt=100A/μ		161		nC	

A: The value of R $_{\theta JA}$ is measured with the device mounted on 1in 2 FR-4 board with 2oz. Copper, in a still air environment with T $_A$ =25°C. The Power dissipation P $_{DSM}$ is based on R $_{\theta JA}$ and the maximum allowed junction temperature of 150°C. The value in any given application depends on the user's specific board design, and the maximum temperature of 175°C may be used if the PCB allows it.

- B. The power dissipation P_D is based on $T_{J(MAX)}$ =175°C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.
- C: Repetitive rating, pulse width limited by junction temperature T_{J(MAX)}=175°C.
- D. The R $_{\theta JA}$ is the sum of the thermal impedence from junction to case R $_{\theta JC}$ and case to ambient.
- E. The static characteristics in Figures 1 to 6 are obtained using <300 $\,\mu s$ pulses, duty cycle 0.5% max.
- F. These curves are based on the junction-to-case thermal impedence which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of $T_{J(MAX)}$ =175°C.
- G. The maximum current rating is limited by bond-wires.
- H. These tests are performed with the device mounted on 1 in 2 FR-4 board with 2oz. Copper, in a still air environment with T_A=25°C. The SOA curve provides a single pulse rating.
- *This device is guaranteed green after data code 8X11 (Sep 1 ST 2008).

Rev1: Sep. 2008

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TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

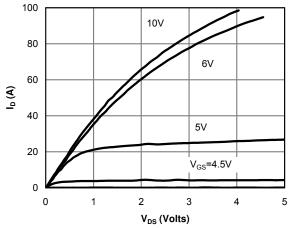
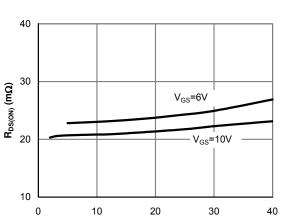


Fig 1: On-Region Characteristics



 ${\rm I_D}\left({\rm A} \right)$ Figure 3: On-Resistance vs. Drain Current and Gate Voltage

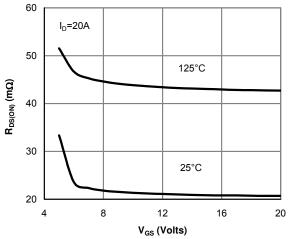


Figure 5: On-Resistance vs. Gate-Source Voltage

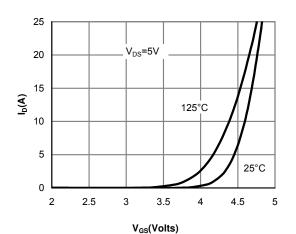


Figure 2: Transfer Characteristics

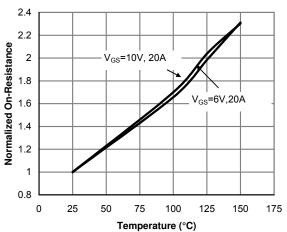


Figure 4: On-Resistance vs. Junction Temperature

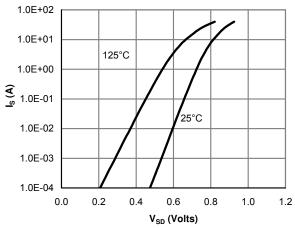


Figure 6: Body-Diode Characteristics

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

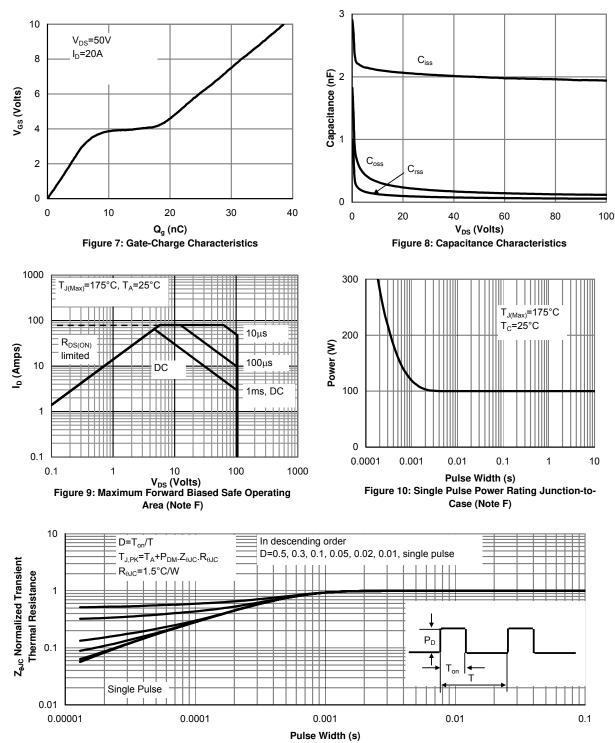


Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

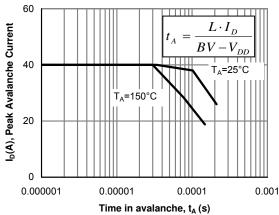


Figure 12: Single Pulse Avalanche capability

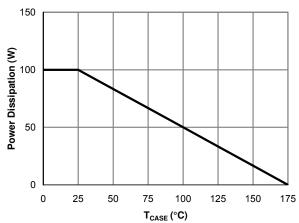


Figure 13: Power De-rating (Note B)

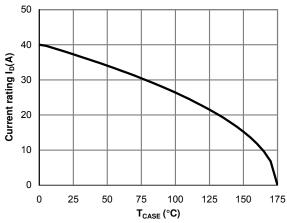


Figure 14: Current De-rating (Note B)

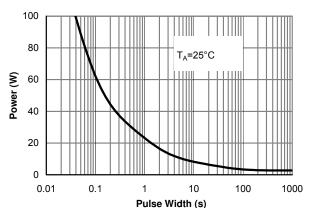


Figure 15: Single Pulse Power Rating Junction-to-Ambient (Note H)

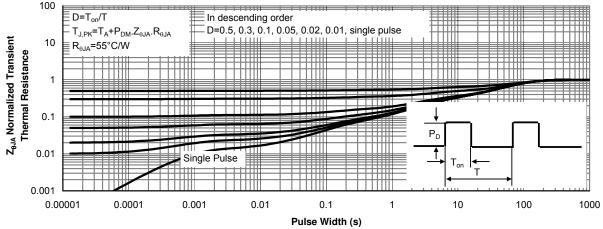
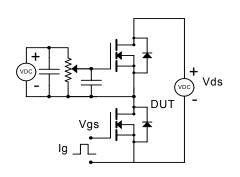
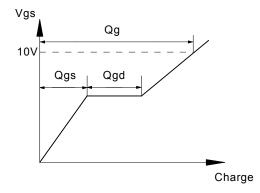


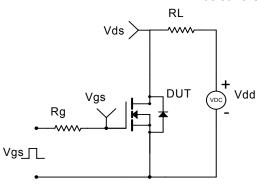
Figure 16: Normalized Maximum Transient Thermal Impedance (Note H)

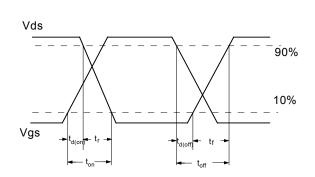
Gate Charge Test Circuit & Waveform



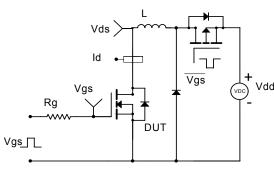


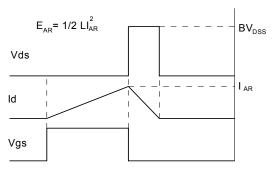
Resistive Switching Test Circuit & Waveforms





Unclamped Inductive Switching (UIS) Test Circuit & Waveforms





Diode Recovery Test Circuit & Waveforms

